



CERTIFICATE OF ACCREDITATION

The ANSI National Accreditation Board

Hereby attests that

Crestwood Technology Group, LLC

Suite 139, 1 Odell Plaza
Yonkers, NY 10701

Fulfills the requirements of

ISO/IEC 17025:2017

and

AS6171 Detection of Suspect/Counterfeit Parts Accreditation Program

In the field of

TESTING

This certificate is valid only when accompanied by a current scope of accreditation document.
The current scope of accreditation can be verified at www.anab.org.

Jason Stine, Vice President

Expiry Date: 21 August 2028

Certificate Number: AT-3303



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory
quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

Crestwood Technology Group, LLC

Suite 139, 1 Odell Plaza

Yonkers, NY 10701

Michael Fils-Aimé michael.fils-aime@blueravencorp.com

914 231 8137

TESTING

ISO/IEC 17025 Accreditation Granted: **13 August 2026**

Certificate Number: **AT-3303**

Certificate Expiry Date: **21 August 2028**

In recognition of a successful assessment to ISO/IEC 17025:2017 General Requirements for the competence of Testing and Calibration Laboratories, AS6171 General Requirements, and the requirements of the ANAB SR 2429 – Labs Performing Detection of Suspect/Counterfeit Parts Under AS6171 program, accreditation is granted to the **Crestwood Technology Group, LLC** to perform the following AS6171 slash sheet tests:

Non-Destructive

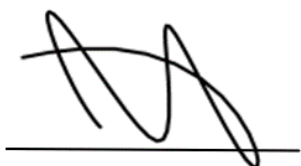
Specific Tests and/or Properties Measured	Specification, Standard, Method, or Test Technique	Items, Materials or Product Tested	Key Equipment or Technology
Packaging Configuration and Dimension	AS6081, 4.2.6.4.1 AS6171/2 (Method E) IDEA-STD-1010 CCAP	Electrical, Electronic and Electromechanical (EEE) Components	Caliper, Keyence
External Visual Inspection	AS6081, 4.2.6.4.2.1 AS6081, 4.2.6.4.2.2 AS6171/2 (Method A & B) IDEA-STD-1010 CCAP		Microscope, Camera, Scale
Elemental Content by XRF	AS6081, 4.2.6.4.5 AS6171/3 IDEA-STD-1010 CCAP		Fisher X-Ray XDAL 237
Radiographic Examination/Inspection	AS6081, 4.2.6.4.4 AS6171/5 IDEA-STD-1010 CCAP		TruView 10 Premium Source 130
Scanning Acoustic Microscopy Inspection	AS6081, 4.2.6.3 C AS6171/6 IDEA-STD-1010		OKOS Vue 400-P

Mechanical Testing

Specific Tests and/or Properties Measured	Specification, Standard, Method, or Test Technique	Items, Materials or Product Tested	Key Equipment or Technology
Solvent Test for Remarking and Resurfacing	AS6081, 4.2.6.4.3B AS6171/2 IDEA-STD-1010 CCAP	Electrical, Electronic and Electromechanical (EEE) Components	Mark-Scrape test Chemical Solution Dynasolve, Acetone, Mineral Spirits
Decapsulation and Die Verification	AS6081, 4.2.6.4.6 AS6171/4 IDEA-STD-1010 CCAP		RKD Elite Etch 7000, FALIT Laser Oven
Solderability	IPC J-STD-002 IDEA-STD-1010		Ascentech Gen 3 Must System III Hakko FX-301B
Fourier Transform Infrared Spectroscopy (FTIR)	AS6171/9		Thermo Electron S10 Spectrometer

Electrical

Specific Tests and/or Properties Measured	Specification, Standard, Method, or Test Technique	Items, Materials or Product Tested	Key Equipment or Technology
LCR	AS6171/7	Electrical, Electronic and Electromechanical (EEE) Components	Hioki LCR Meter IM3536



Jason Stine, Vice President